

T081610_T120510_STRH100N10FSY3
NO REPORT AVAILABLE

Jean-Marie Lauenstein, et al.,
“Single Event Effects Testing of the STMicro Engineering STRH100N10FSY3
100 V n-type Power MOSFET”

Contact Jean-Marie Lauenstein
jean.m.lauenstein@nasa.gov
To request report # T081610_T120510_STRH100N10FSY3